

# DOSEMI

# IGBT

## DG75A08TDFQ

### 750V/75A IGBT with SIC Diode

### General Description

DOSEMI IGBT Power Discrete provides ultra low conduction loss as well as low switching loss. They are designed for the applications such as solar power.

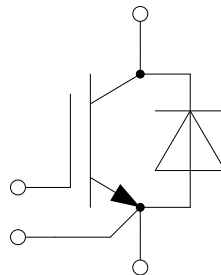
### Features

- Low  $V_{CE(sat)}$  Fast IGBT technology
- Low switching loss
- Maximum junction temperature 175°C
- $V_{CE(sat)}$  with positive temperature coefficient
- Very low reverse recovery loss based on SIC diode

### Typical Applications

- Solar power
- UPS
- 3-level-application

### Equivalent Circuit Schematic



Type	Package	Marking	Shipping
DG75A08TDFQ	TO-247PLUS-4L	DG75A08TDFQ	30Units/Tube

**Absolute Maximum Ratings**  $T_C=25^{\circ}\text{C}$  unless otherwise noted**IGBT**

Symbol	Description	Value	Unit
$V_{CES}$	Collector-Emitter Voltage	750	V
$V_{GES}$	Gate-Emitter Voltage	$\pm 20$	V
$I_C$	Collector Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=100^{\circ}\text{C}$	100	A
		75	A
$I_{CRM}$	Repetitive Peak Collector Current tp limited by $T_{vjop}$	225	A
$P_D$	Maximum Power Dissipation @ $T_{vj}=175^{\circ}\text{C}$	378	W

**Diode**

Symbol	Description	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	750	V
$I_F$	Diode Continuous Forward Current @ $T_C=25^{\circ}\text{C}$ @ $T_C=100^{\circ}\text{C}$	100	A
		75	A
$I_{FRM}$	Repetitive Peak Forward Current tp limited by $T_{vjop}$	225	A

**Discrete**

Symbol	Description	Values	Unit
$T_{vjop}$	Operating Junction Temperature	-40 to +175	$^{\circ}\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to +150	$^{\circ}\text{C}$
$T_S$	Soldering Temperature, 1.6mm from case for 10s	260	$^{\circ}\text{C}$

**IGBT Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=75\text{A}, V_{GE}=15\text{V}, T_{vj}=25^\circ\text{C}$		1.45	1.90	V
		$I_C=75\text{A}, V_{GE}=15\text{V}, T_{vj}=150^\circ\text{C}$		1.80		
		$I_C=75\text{A}, V_{GE}=15\text{V}, T_{vj}=175^\circ\text{C}$		1.90		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=1.5\text{mA}, V_{CE}=V_{GE}, T_{vj}=25^\circ\text{C}$	3.5	4.0	4.5	V
$I_{CES}$	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$			200	$\mu\text{A}$
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_{vj}=25^\circ\text{C}$			100	nA
$R_{Gint}$	Internal Gate Resistance			0		$\Omega$
$C_{ies}$	Input Capacitance			2.89		nF
$C_{res}$	Reverse Transfer Capacitance	$V_{CE}=25\text{V}, f=100\text{kHz}, V_{GE}=0\text{V}$		0.01		nF
$C_{oes}$	Output Capacitance			0.77		nF
$Q_G$	Gate Charge	$V_{GE}=-10\dots+15\text{V}$		0.17		$\mu\text{C}$
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=75\text{A}, R_G=5.1\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=25^\circ\text{C}$		30		ns
$t_r$	Rise Time			20		ns
$t_{d(off)}$	Turn-Off Delay Time			87		ns
$t_f$	Fall Time			27		ns
$E_{on}$	Turn-On Switching Loss			0.98		mJ
$E_{off}$	Turn-Off Switching Loss			1.05		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=75\text{A}, R_G=5.1\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=150^\circ\text{C}$		34		ns
$t_r$	Rise Time			21		ns
$t_{d(off)}$	Turn-Off Delay Time			108		ns
$t_f$	Fall Time			71		ns
$E_{on}$	Turn-On Switching Loss			1.15		mJ
$E_{off}$	Turn-Off Switching Loss			1.55		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=75\text{A}, R_G=5.1\Omega, L_S=40\text{nH}, V_{GE}=\pm 15\text{V}, T_{vj}=175^\circ\text{C}$		36		ns
$t_r$	Rise Time			22		ns
$t_{d(off)}$	Turn-Off Delay Time			113		ns
$t_f$	Fall Time			82		ns
$E_{on}$	Turn-On Switching Loss			1.21		mJ
$E_{off}$	Turn-Off Switching Loss			1.63		mJ

**Diode Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_F$	Diode Forward Voltage	$I_F=75\text{A}, V_{GE}=0\text{V}, T_{vj}=25^\circ\text{C}$		1.55	2.00	V
		$I_F=75\text{A}, V_{GE}=0\text{V}, T_{vj}=150^\circ\text{C}$		1.90		
		$I_F=75\text{A}, V_{GE}=0\text{V}, T_{vj}=175^\circ\text{C}$		2.00		
$Q_r$	Recovered Charge	$V_R=400\text{V}, I_F=75\text{A},$ $-di/dt=3080\text{A}/\mu\text{s}, L_s=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=25^\circ\text{C}$		0.26		$\mu\text{C}$
$t_{rr}$	Recovered Time			26		ns
$I_{RM}$	Peak Reverse Recovery Current			15		A
$E_{rec}$	Reverse Recovery Energy			0.01		mJ
$Q_r$	Recovered Charge	$V_R=400\text{V}, I_F=75\text{A},$ $-di/dt=2850\text{A}/\mu\text{s}, L_s=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=150^\circ\text{C}$		0.26		$\mu\text{C}$
$t_{rr}$	Recovered Time			26		ns
$I_{RM}$	Peak Reverse Recovery Current			15		A
$E_{rec}$	Reverse Recovery Energy			0.02		mJ
$Q_r$	Recovered Charge	$V_R=400\text{V}, I_F=75\text{A},$ $-di/dt=2860\text{A}/\mu\text{s}, L_s=40\text{nH},$ $V_{GE}=-15\text{V}, T_{vj}=175^\circ\text{C}$		0.25		$\mu\text{C}$
$t_{rr}$	Recovered Time			26		ns
$I_{RM}$	Peak Reverse Recovery Current			15		A
$E_{rec}$	Reverse Recovery Energy			0.02		mJ

**Discrete Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
$R_{thJC}$	Junction-to-Case (per IGBT)			0.396	K/W
	Junction-to-Case (per Diode)			0.405	
$R_{thJA}$	Junction-to-Ambient		40		K/W

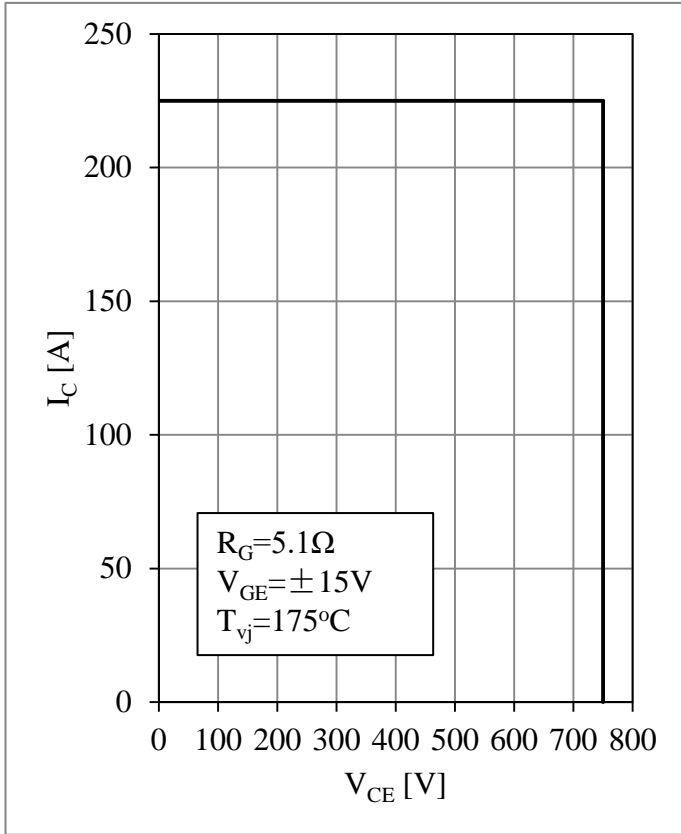


Fig 1. RBSOA

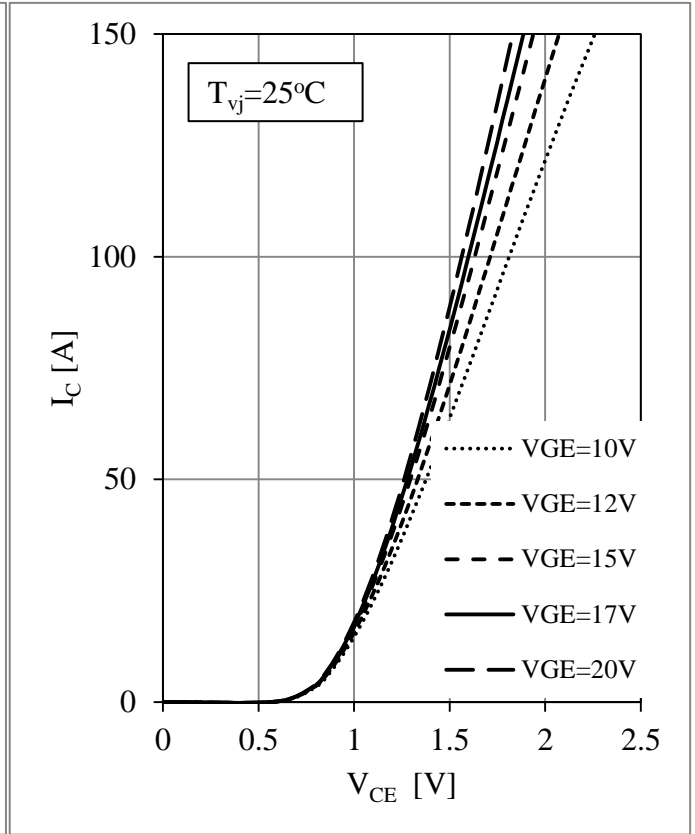


Fig 2. IGBT Output Characteristics

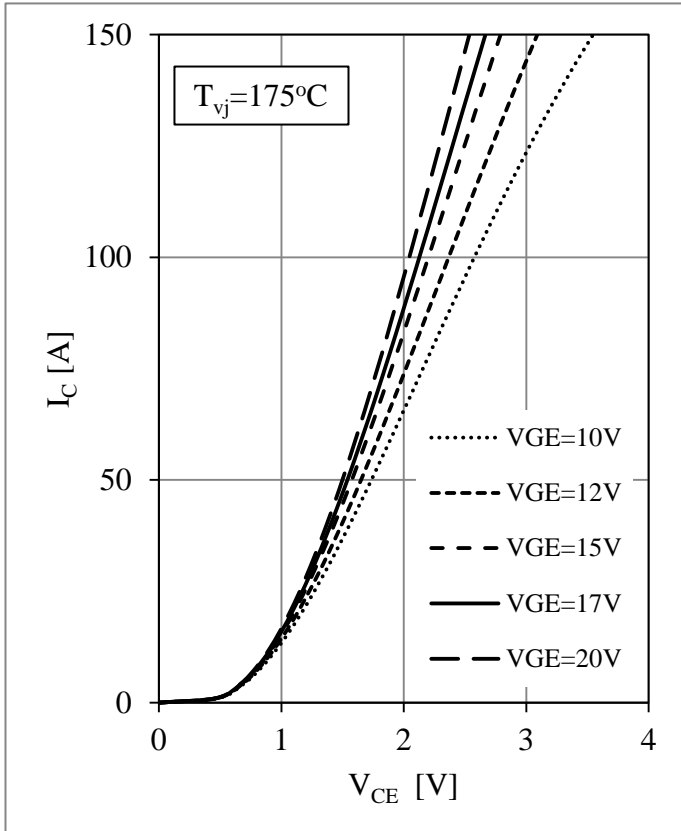


Fig 3. IGBT Output Characteristics

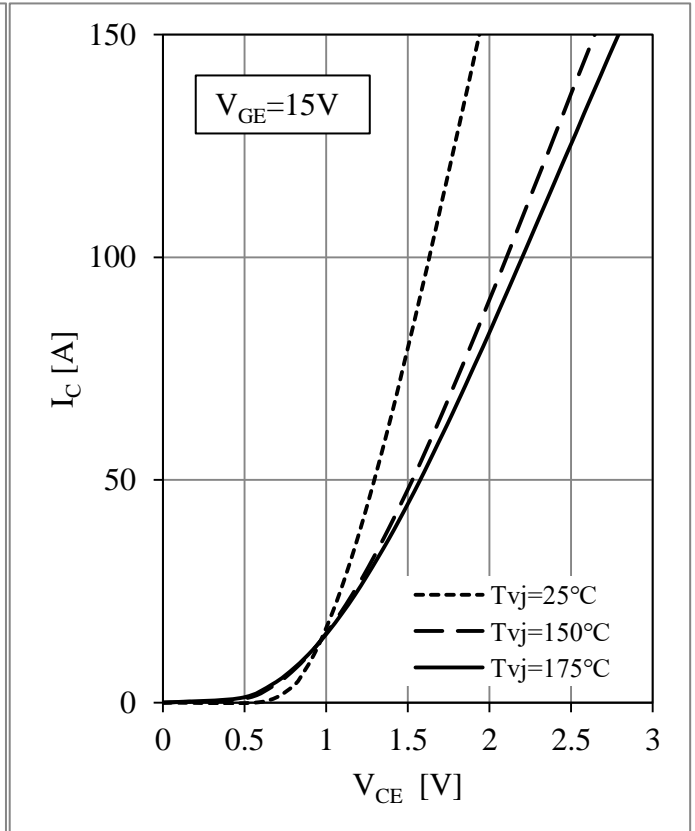


Fig 4. IGBT Output Characteristics

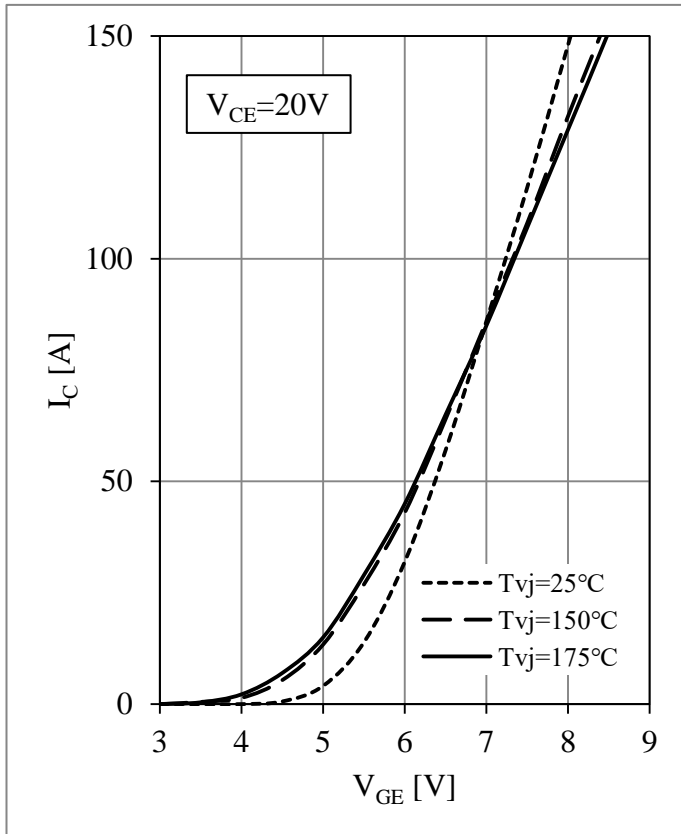


Fig 5. IGBT Transfer Characteristics

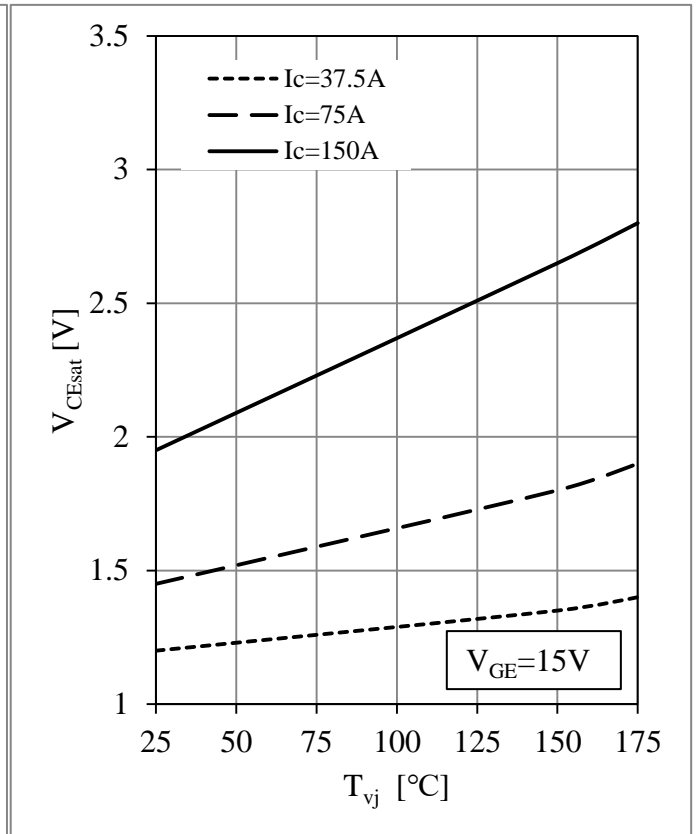


Fig 6. Collector-emitter saturation voltage vs  $T_{vj}$

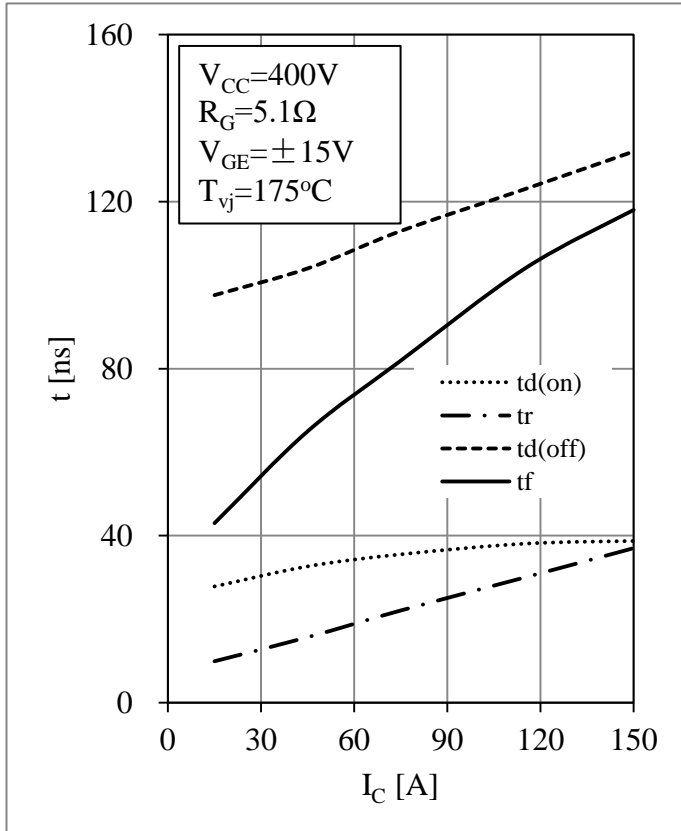


Fig 7. IGBT Switching Times as.  $I_c$

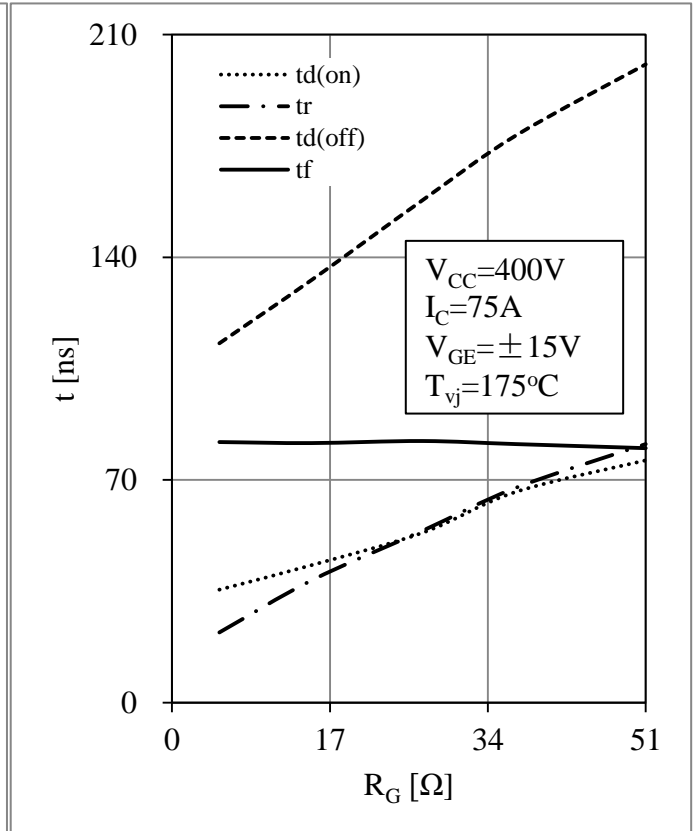


Fig 8. IGBT Switching Times as.  $R_G$

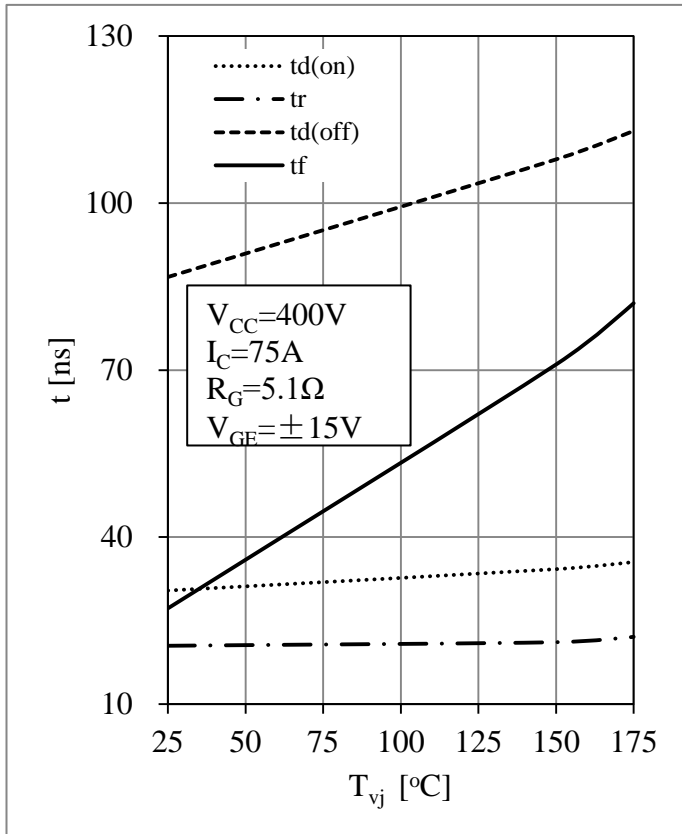


Fig 9. IGBT Switching Times as.  $T_{vj}$

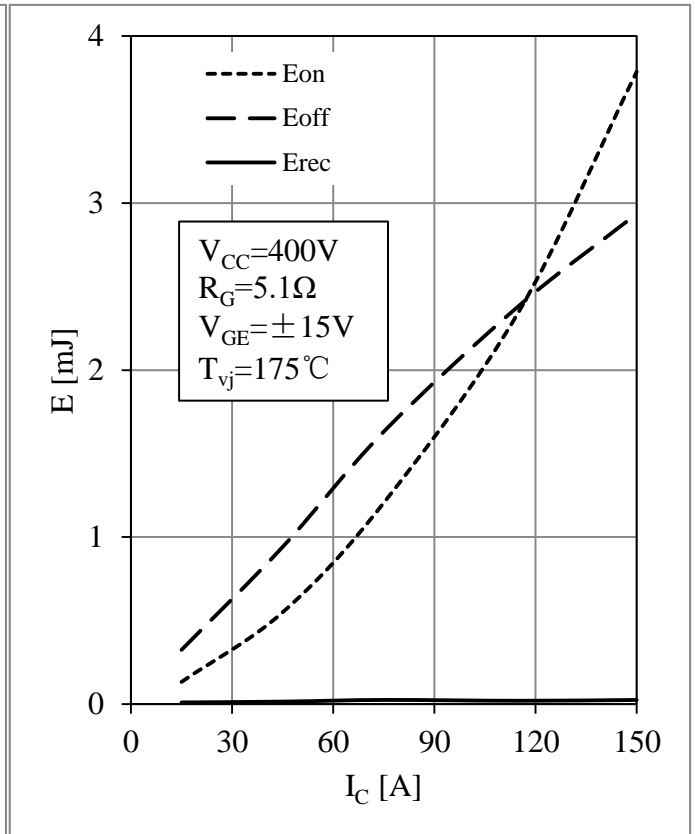


Fig 10. Switching Energy Loss vs.  $I_C$

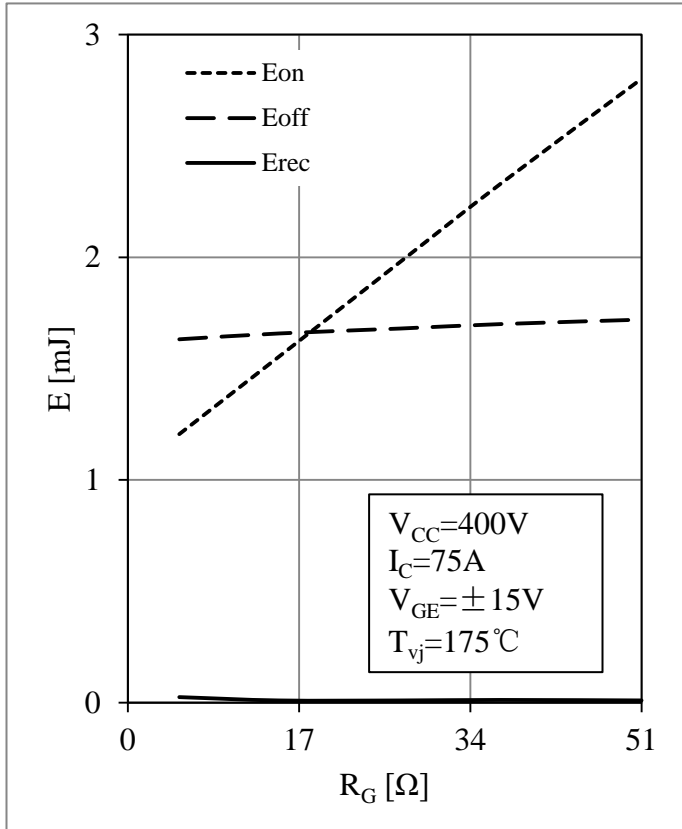


Fig 11. Switching Energy Loss vs.  $R_G$

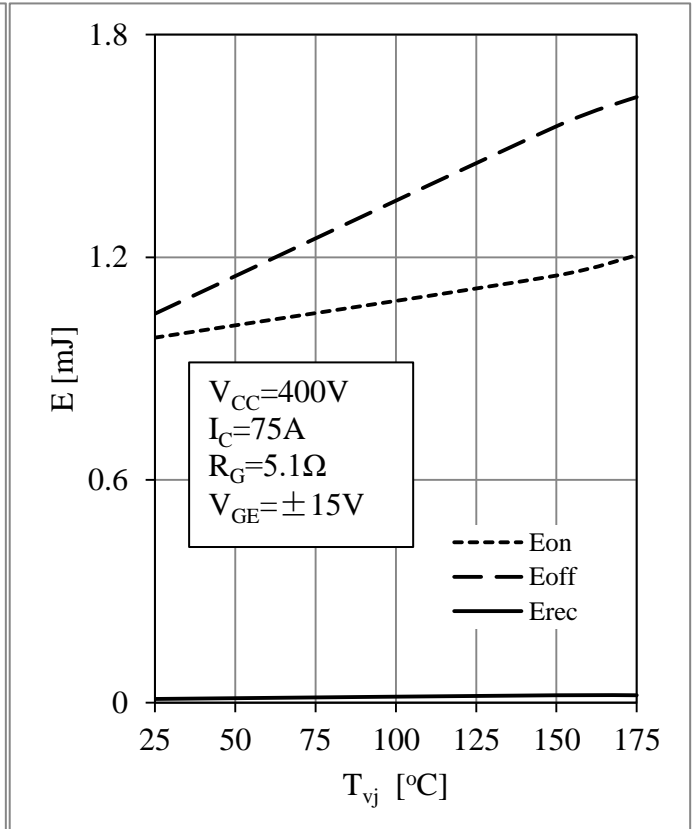


Fig 12. Switching Energy Loss vs.  $T_{vj}$

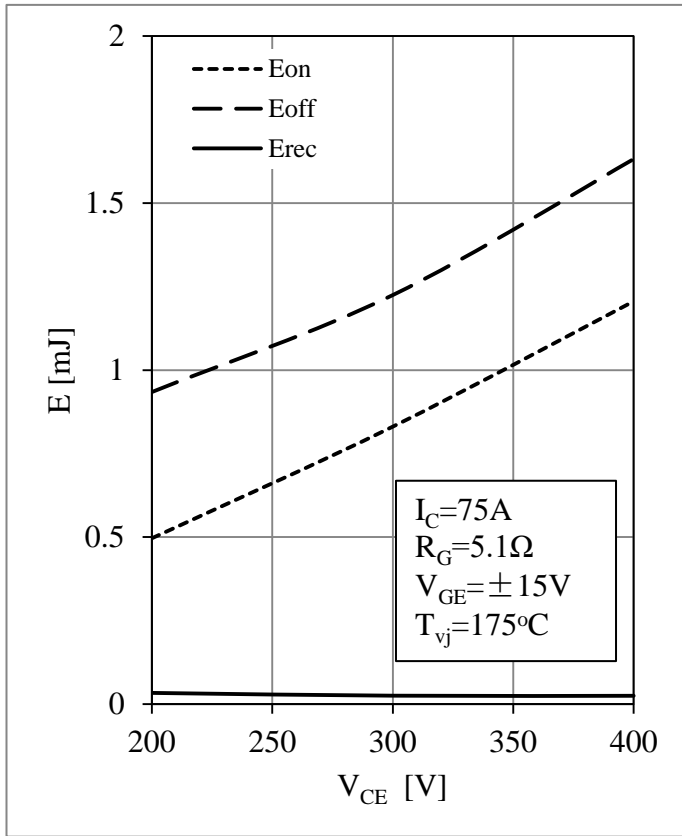


Fig 13. Switching Energy Loss vs.  $V_{CE}$

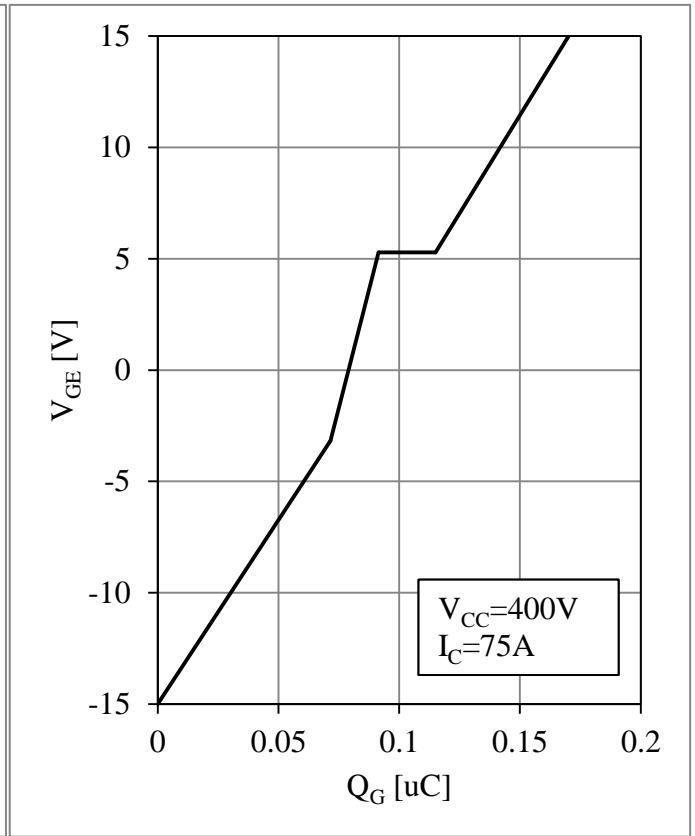


Fig 14. IGBT Gate Charge Characteristic

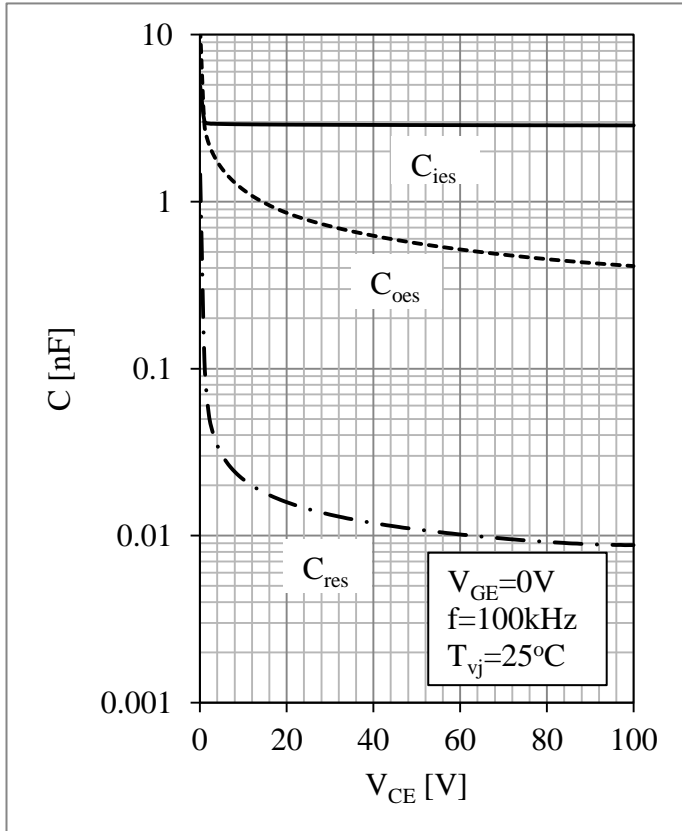


Fig 15. IGBT Capacity Characteristic

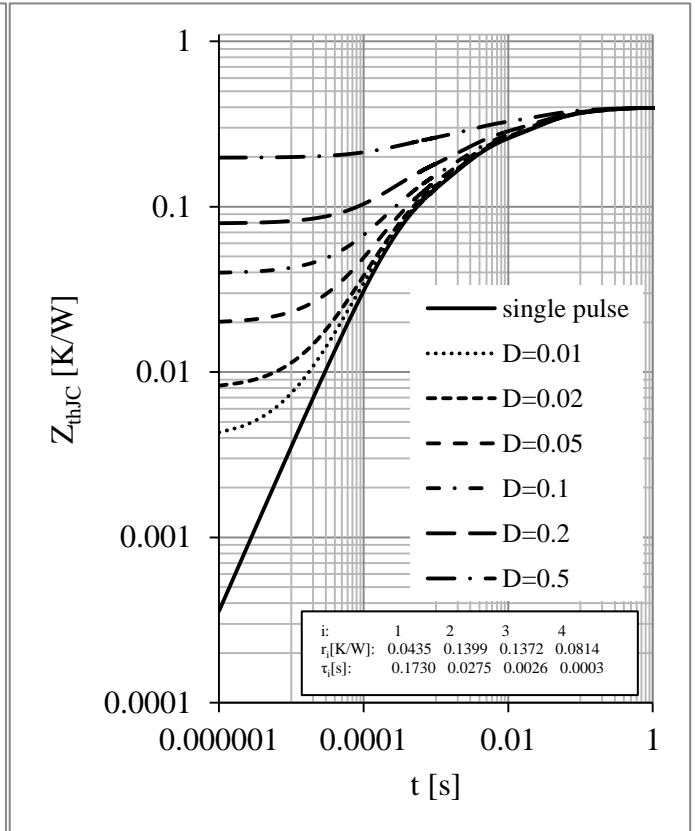


Fig 16. IGBT Transient Thermal Impedance



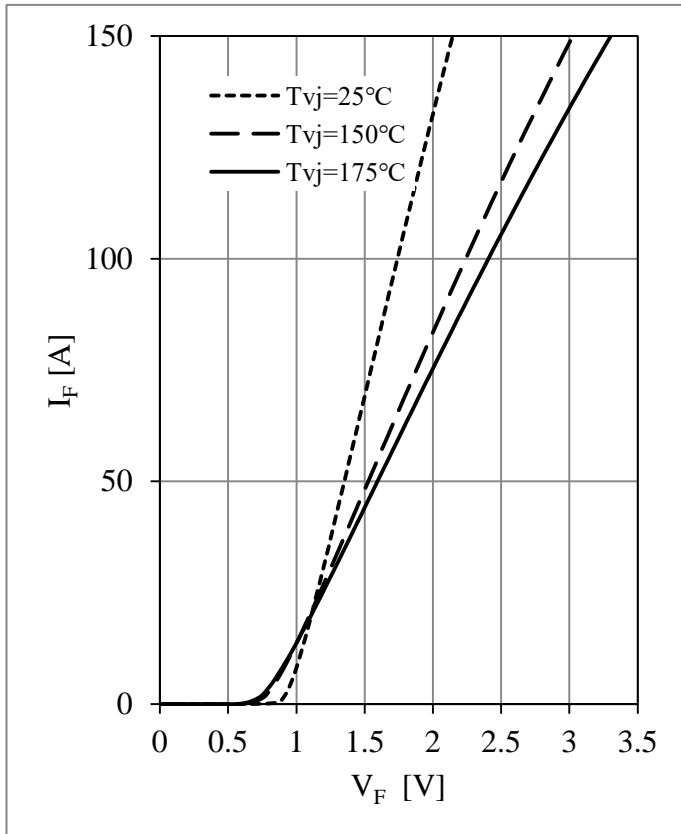


Fig 17. Diode Forward Characteristics

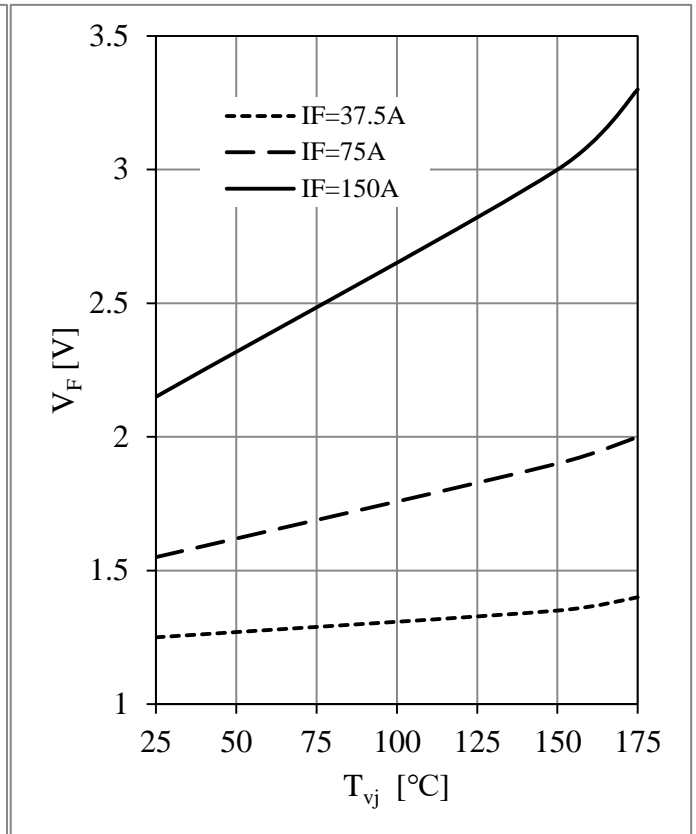


Fig 18. Diode Forward Voltage Vs  $T_{vj}$

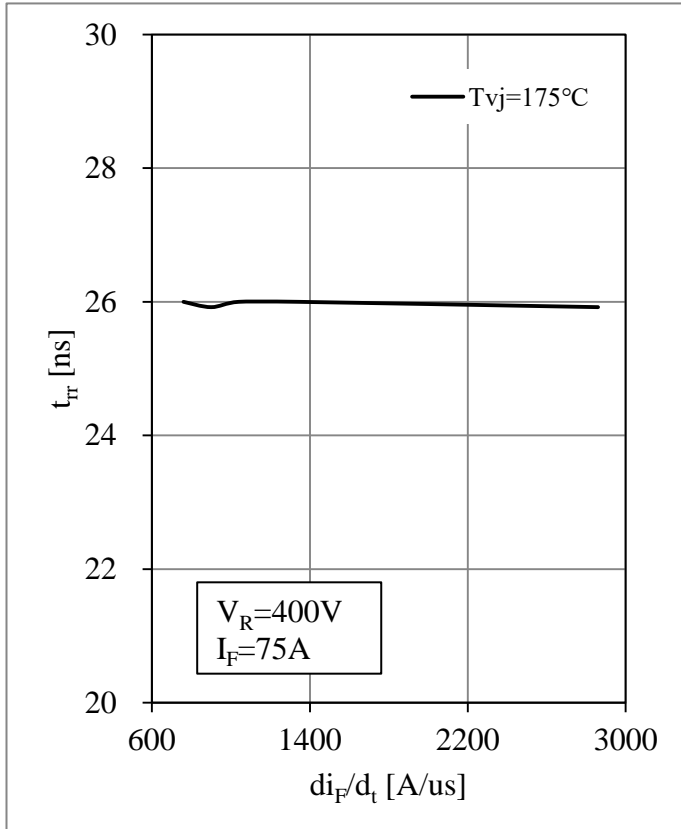


Fig 19. Reverse Recovery Time vs. diF/dt

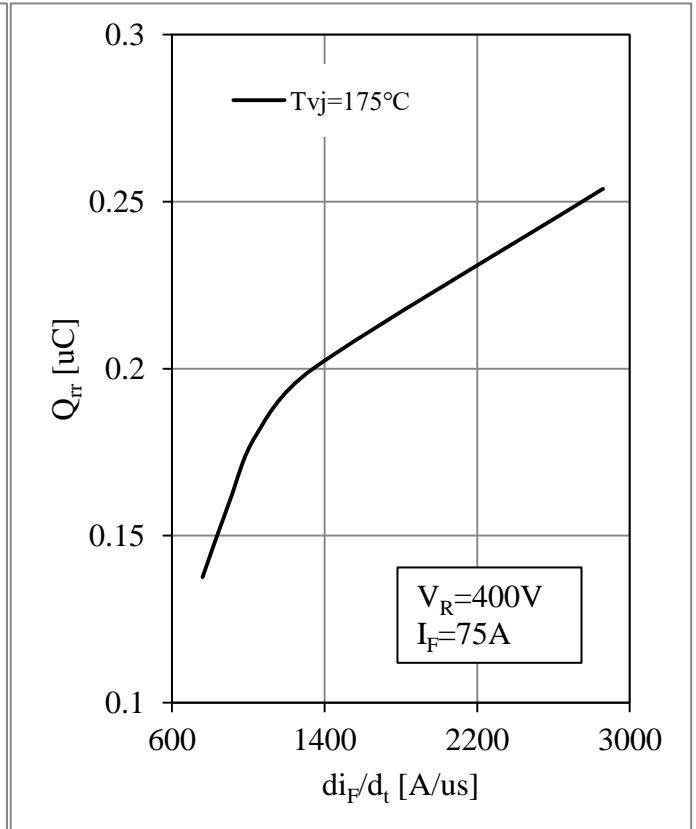


Fig 20. Reverse Recovery Charge vs. diF/dt

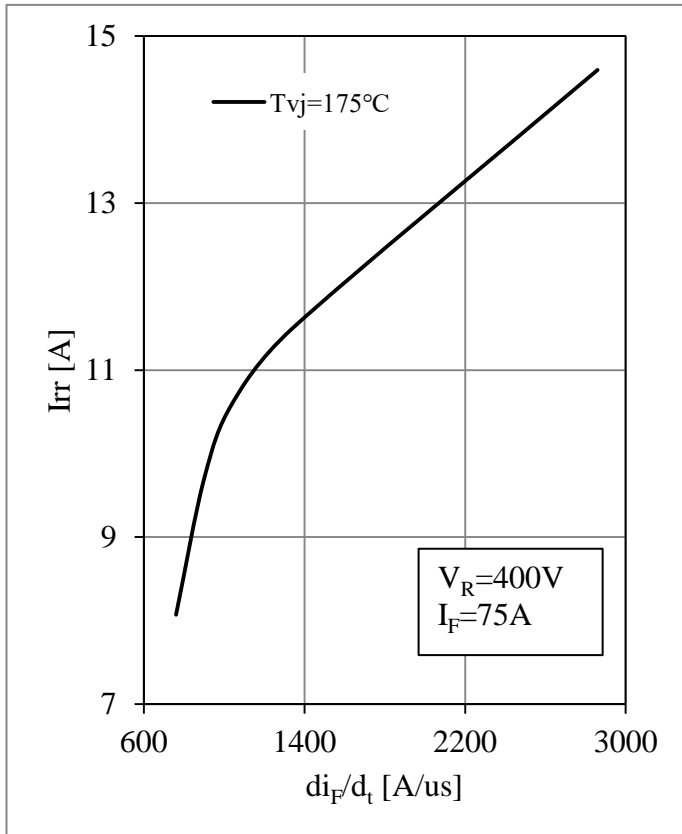


Fig 21. Reverse Recovery Current vs.  $di_F/dt$

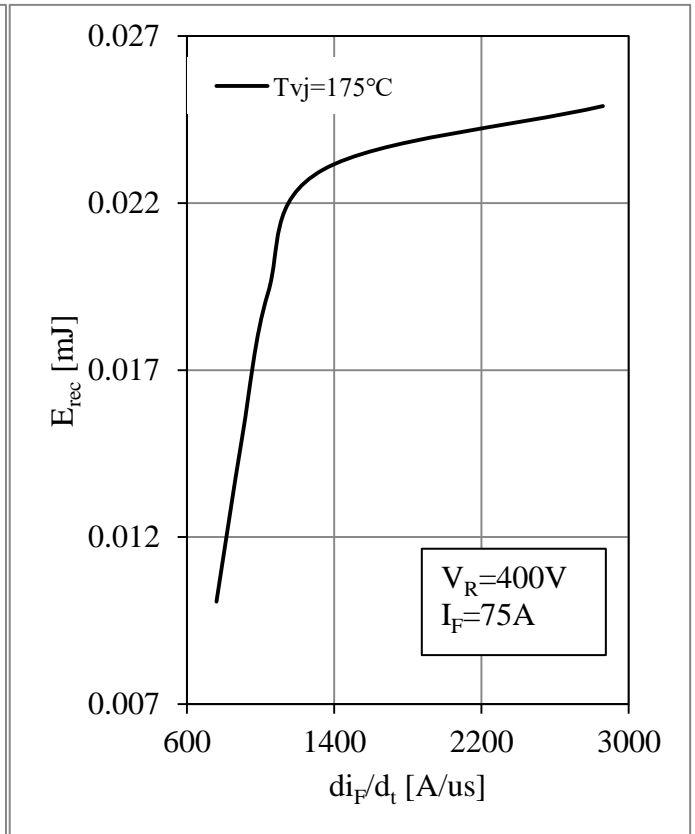


Fig 22. Reverse Energy Losses vs.  $di_F/dt$

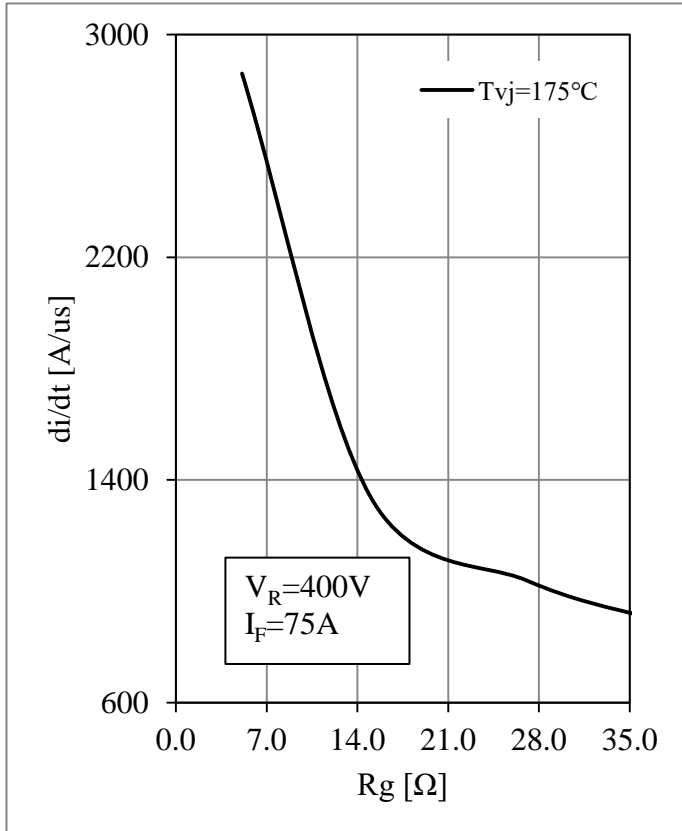


Fig 23.  $di_F/dt$  vs  $R_g$

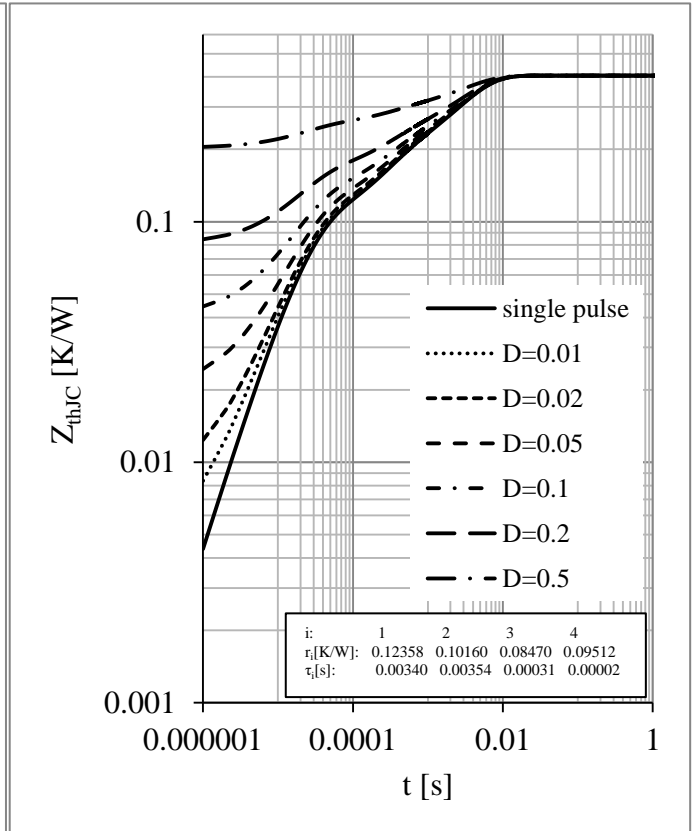
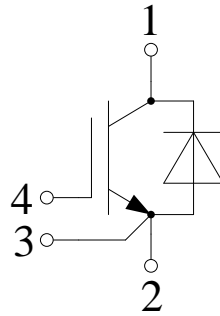


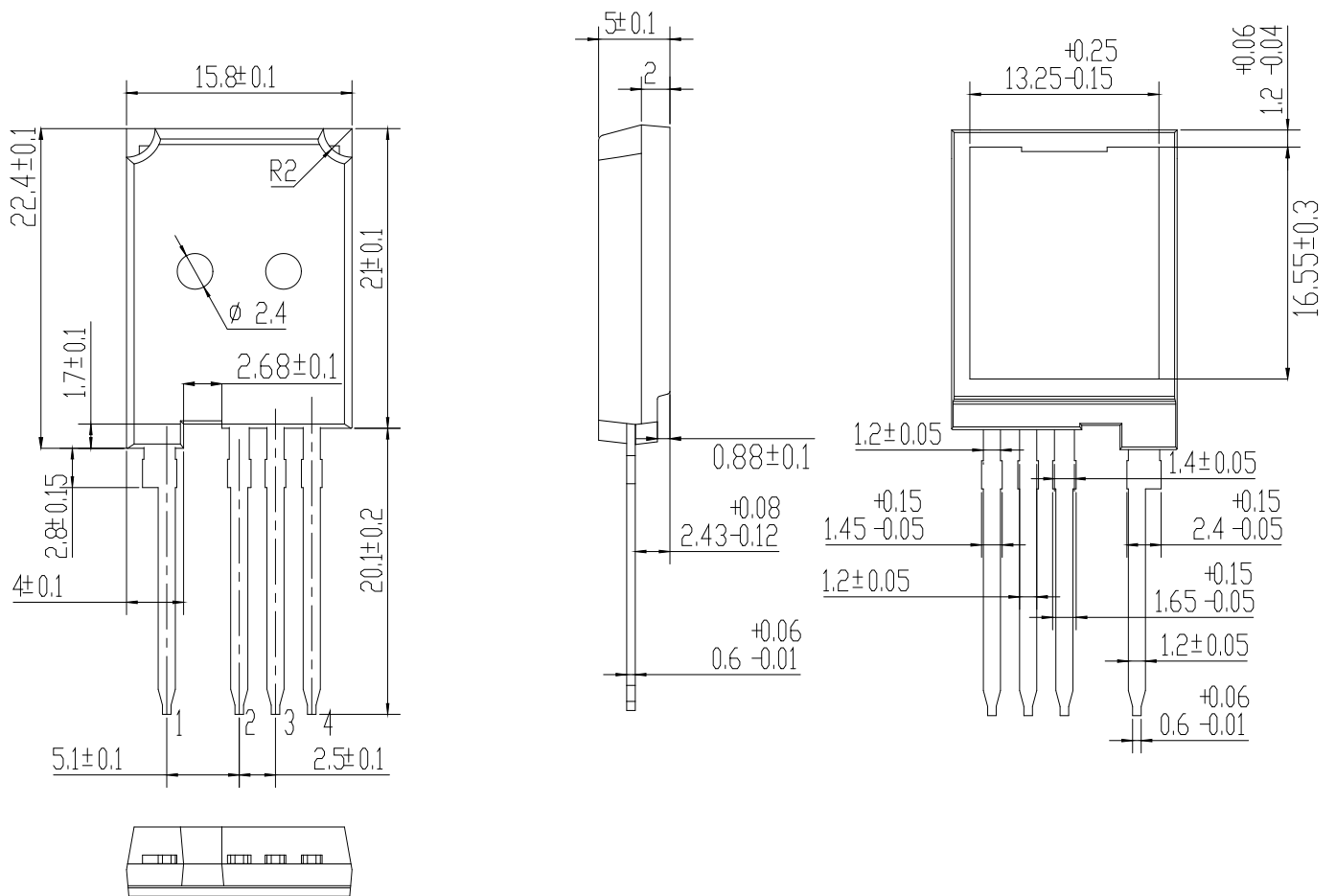
Fig 24. Diode Transient Thermal Impedance

**Circuit Schematic**



**Package Dimensions**

Dimensions in Millimeters



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